

### 8M-BIT [1024K x 8 / 512K x 16] SINGLE VOLTAGE 5V ONLY FLASH MEMORY

#### **FEATURES**

#### **GENERAL FEATURES**

- Single Power Supply Operation
  - 4.5 to 5.5 volt for read, erase, and program operations
- 1,048,576 x 8 / 524,288 x 16 switchable
- · Boot Sector Architecture
  - T = Top Boot Sector
  - B = Bottom Boot Sector
- Sector Structure
  - 16K-Byte x 1, 8K-Byte x 2, 32K-Byte x 1, and 64K-Byte x 15
- · Sector protection
  - Hardware method to disable any combination of sectors from program or erase operations
  - Temporary sector unprotected allows code changes in previously locked sectors
- Latch-up protected to 100mA from -1V to Vcc + 1V
- · Compatible with JEDEC standard
  - Pinout and software compatible to single power supply Flash

#### **PERFORMANCE**

- · High Performance
  - Access time: 70ns
  - Byte/Word program time: 9us/11us (typical)
  - Erase time: 0.7s/sector, 8s/chip (typical)
- · Low Power Consumption
  - Low active read current: 40mA (maximum) at 5MHz
  - Low standby current: 1uA (typical)
- Minimum 100,000 erase/program cycle
- 20 years data retention

#### **SOFTWARE FEATURES**

- · Erase Suspend/ Erase Resume
  - Suspends sector erase operation to read data from or program data to another sector which is not being erased
- Status Reply
  - Data# Polling & Toggle bits provide detection of program and erase operation completion

#### HARDWARE FEATURES

- Ready/Busy# (RY/BY#) Output
  - Provides a hardware method of detecting program and erase operation completion
- Hardware Reset (RESET#) Input
  - Provides a hardware method to reset the internal state machine to read mode

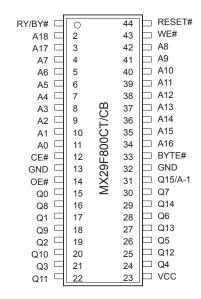
#### **PACKAGE**

- 44-Pin SOP
- 48-Pin TSOP
- 48-Ball TFBGA (6x8mm)
- · All Pb-free devices are RoHS Compliant
- · All non RoHS Compliant devices are not recommeded for new design in

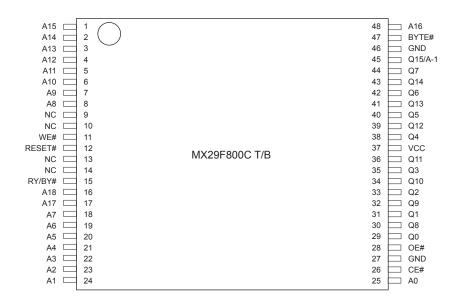


### **PIN CONFIGURATIONS**

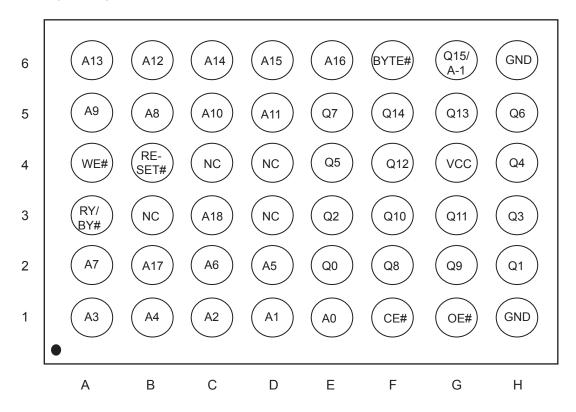
44 SOP(500mil)



### 48 TSOP(TYPE I) (12mm x 20mm)



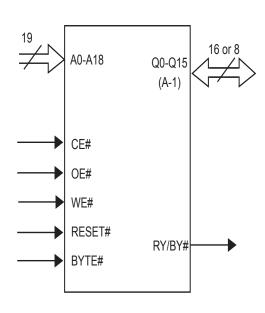
### 48-Ball TFBGA (6x8mm)



#### **PIN DESCRIPTION**

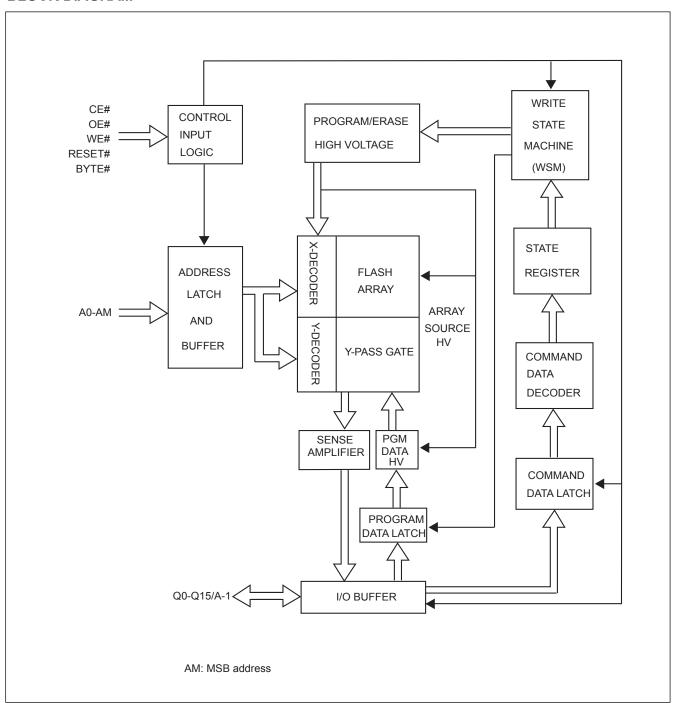
SYMBOL	PIN NAME
A0~A18	Address Input
Q0~Q14	Data Input/Output
Q15/A-1	Q15(Word mode)/LSB addr(Byte mode)
CE#	Chip Enable Input
WE#	Write Enable Input
BYTE#	Word/Byte Selection input
RESET#	Hardware Reset Pin/Sector Protect
05#	
OE#	Output Enable Input
RY/BY#	Ready/Busy Output
VCC	Power Supply Pin (+5V)
GND	Ground Pin

### **LOGIC SYMBOL**





### **BLOCK DIAGRAM**





**Table 1. SECTOR STRUCTURE** 

### MX29F800CT TOP BOOT SECTOR ADDRESS TABLE

Sector	Sector Size		Addre	ss range			Sec	ctor A	ddress	5	
Gector	Byte Mode	Word Mode	Byte Mode (x8)	Word Mode(x16)	A18	A17	A16	A15	A14	A13	A12
SA0	64Kbytes	32Kwords	00000h-0FFFFh	00000h-07FFFh	0	0	0	0	Χ	Х	X
SA1	64Kbytes	32Kwords	10000h-1FFFFh	08000h-0FFFFh	0	0	0	1	Χ	Χ	Х
SA2	64Kbytes	32Kwords	20000h-2FFFFh	10000h-17FFFh	0	0	1	0	Χ	Х	X
SA3	64Kbytes	32Kwords	30000h-3FFFFh	18000h-1FFFFh	0	0	1	1	Χ	Х	X
SA4	64Kbytes	32Kwords	40000h-4FFFFh	20000h-27FFFh	0	1	0	0	Χ	Χ	Х
SA5	64Kbytes	32Kwords	50000h-5FFFFh	28000h-2FFFFh	0	1	0	1	Х	Х	X
SA6	64Kbytes	32Kwords	60000h-6FFFFh	30000h-37FFFh	0	1	1	0	Χ	Χ	X
SA7	64Kbytes	32Kwords	70000h-7FFFFh	38000h-3FFFFh	0	1	1	1	Χ	Χ	X
SA8	64Kbytes	32Kwords	80000h-8FFFFh	40000h-47FFFh	1	0	0	0	Χ	Χ	X
SA9	64Kbytes	32Kwords	90000h-9FFFFh	48000h-4FFFFh	1	0	0	1	Χ	Χ	X
SA10	64Kbytes	32Kwords	A0000h-AFFFFh	50000h-57FFFh	1	0	1	0	Χ	Χ	X
SA11	64Kbytes	32Kwords	B0000h-BFFFFh	58000h-5FFFFh	1	0	1	1	Χ	Χ	X
SA12	64Kbytes	32Kwords	C0000h-CFFFFh	60000h-67FFFh	1	1	0	0	Χ	Χ	X
SA13	64Kbytes	32Kwords	D0000h-DFFFFh	68000h-6FFFFh	1	1	0	1	Χ	Χ	X
SA14	64Kbytes	32Kwords	E0000h-EFFFFh	70000h-77FFFh	1	1	1	0	Χ	Χ	X
SA15	32Kbytes	16Kwords	F0000h-F7FFFh	78000h-7BFFFh	1	1	1	1	0	Χ	X
SA16	8Kbytes	4Kwords	F8000h-F9FFFh	7C000h-7CFFFh	1	1	1	1	1	0	0
SA17	8Kbytes	4Kwords	FA000h-FBFFFh	7D000h-7DFFFh	1	1	1	1	1	0	1
SA18	16Kbytes	8Kwords	FC000h-FFFFFh	7E000h-7FFFFh	1	1	1	1	1	1	X

### MX29F800CB BOTTOM BOOT SECTOR ADDRESS TABLE

Sector	Secto	r Size	Addre	ss range			Se	ctor A	ddress	5	
Jector	Byte Mode	Word Mode	Byte Mode (x8)	Word Mode(x16)	A18	A17	A16	A15	A14	A13	A12
SA0	16Kbytes	8Kwords	00000h-03FFFh	00000h-01FFFh	0	0	0	0	0	0	Х
SA1	8Kbytes	4Kwords	04000h-05FFFh	02000h-02FFFh	0	0	0	0	0	1	0
SA2	8Kbytes	4Kwords	06000h-07FFFh	03000h-03FFFh	0	0	0	0	0	1	1
SA3	32Kbytes	16Kwords	08000h-0FFFFh	04000h-07FFFh	0	0	0	0	1	Х	X
SA4	64Kbytes	32Kwords	10000h-1FFFFh	08000h-0FFFFh	0	0	0	1	Х	Х	X
SA5	64Kbytes	32Kwords	20000h-2FFFFh	10000h-17FFFh	0	0	1	0	Х	Х	X
SA6	64Kbytes	32Kwords	30000h-3FFFFh	18000h-1FFFFh	0	0	1	1	Х	Х	X
SA7	64Kbytes	32Kwords	40000h-4FFFFh	20000h-27FFFh	0	1	0	0	Х	Х	X
SA8	64Kbytes	32Kwords	50000h-5FFFFh	28000h-2FFFFh	0	1	0	1	Х	Х	X
SA9	64Kbytes	32Kwords	60000h-6FFFFh	30000h-37FFFh	0	1	1	0	Х	Х	X
SA10	64Kbytes	32Kwords	70000h-7FFFFh	38000h-3FFFFh	0	1	1	1	Х	Х	X
SA11	64Kbytes	32Kwords	80000h-8FFFFh	40000h-47FFFh	1	0	0	0	Х	Х	X
SA12	64Kbytes	32Kwords	90000h-9FFFFh	48000h-4FFFFh	1	0	0	1	Х	Χ	X
SA13	64Kbytes	32Kwords	A0000h-AFFFFh	50000h-57FFFh	1	0	1	0	Х	Х	X
SA14	64Kbytes	32Kwords	B0000h-BFFFFh	58000h-5FFFFh	1	0	1	1	Х	Х	X
SA15	64Kbytes	32Kwords	C0000h-CFFFFh	60000h-67FFFh	1	1	0	0	Х	Х	X
SA16	64Kbytes	32Kwords	D0000h-DFFFFh	68000h-6FFFFh	1	1	0	1	Х	Χ	X
SA17	64Kbytes	32Kwords	E0000h-EFFFFh	70000h-77FFFh	1	1	1	0	Х	Х	X
SA18	64Kbytes	32Kwords	F0000h-FFFFFh	78000h-7FFFFh	1	1	1	1	Х	Х	Х

**Note:** Address range is A18~A-1 in byte mode and A18~A0 in word mode.



### **Table 2. BUS OPERATION**

Mode Pins	CE#	OE#	WE#	RESET#	Α0	A1	<b>A</b> 6	A9	Q0 ~ Q15
Read Silicon ID	L	L	Н	Н	L	L	Χ	Vhv	C2H (Byte mode)
Manufacture Code									00C2H (Word mode)
Read Silicon ID	L	L	Н	Н	Н	L	Χ	Vhv	D6/58 (Byte mode)
Device Code									22D6/2258(Word mode)
Read	L	L	Н	Н	A0	A1	A6	A9	D <sub>OUT</sub>
Standby	Н	Χ	Χ	Н	Χ	Χ	Χ	Χ	HIGH Z
Output Disable	L	Η	Н	Н	Χ	Χ	Χ	Χ	HIGH Z
Write	L	Н	L	Н	A0	A1	A6	A9	D <sub>IN</sub>
Sector Protect	L	Н	L	Vhv	L	Н	L	Χ	D <sub>IN</sub>
Chip Unprotect	L	Η	L	Vhv	L	Н	Η	Х	D <sub>IN</sub>
Verify Sector Protect/Unprotect	L	L	Н	Н	L	Н	L	Vhv	Code(4)
Reset	Χ	Χ	Х	L	Χ	Х	Χ	Х	HIGH Z

#### Notes:

- 1. Vhv is the very high voltage, 11.5V to 12.5V.
- 2. X means input high (Vih) or input low (Vil).
- 3. SA means sector address: A12~A18.
- 4. Code=00H/XX00H means unprotected. Code=01H/XX01H means protected.



#### REQUIREMENTS FOR READING ARRAY DATA

Read array action is to read the data stored in the array out. While the memory device is in powered up or has been reset, it will automatically enter the status of read array. If the microprocessor wants to read the data stored in array, it has to drive CE# (device enable control pin) and OE# (Output control pin) as Vil, and input the address of the data to be read into address pin at the same time. After a period of read cycle (Tce or Taa), the data being read out will be displayed on output pin for microprocessor to access. If CE# or OE# is Vih, the output will be in tri-state, and there will be no data displayed on output pin at all.

After the memory device completes embedded operation (automatic Erase or Program), it will automatically return to the status of read array, and the device can read the data in any address in the array. In the process of erasing, if the device receives the Erase suspend command, erase operation will be stopped after a period of time no more than Treadyand the device will return to the status of read array. At this time, the device can read the data stored in any address except the sector being erased in the array. In the status of erase suspend, if user wants to read the data in the sectors being erased, the device will output status data onto the output. Similarly, if program command is issued after erase suspend, after program operation is completed, system can still read array data in any address except the sectors to be erased.

The device needs to issue reset command to enable read array operation again in order to arbitrarily read the data in the array in the following two situations:

- 1. In program or erase operation, the programming or erasing failure causes Q5 to go high.
- 2. The device is in auto select mode.

In the two situations above, if reset command is not issued, the device is not in read array mode and system must issue reset command before reading array data.

#### WRITE COMMANDS/COMMAND SEQUENCES

To write a command to the device, system must drive WE# and CE# to Vil, and OE# to Vih. In a command cycle, all address are latched at the later falling edge of CE# and WE#, and all data are latched at the earlier rising edge of CE# and WE#.

Figure 1 illustrates the AC timing waveform of a write command, and Table 3 defines all the valid command sets of the device. System is not allowed to write invalid commands not defined in this datasheet. Writing an invalid command will bring the device to an undefined state.

### **RESET# OPERATION**

Driving RESET# pin low for a period more than Trp will reset the device back to read mode. If the device is in program or erase operation, the reset operation will take at most a period of Tready for the device to return to read array mode. Before the device returns to read array mode, the RY/BY# pin remains low (busy status).

When RESET# pin is held at GND±0.3V, the device consumes standby current(Isb). However, device draws larger current if RESET# pin is held at Vil but not within GND±0.3V.

It is recommended that the system to tie its reset signal to RESET# pin of flash memory, so that the flash memory will be reset during system reset and allows system to read boot code from flash memory.



#### **SECTOR PROTECT OPERATION**

When a sector is protected, program or erase operation will be disabled on these sectors. MX29F800C T/B provides one method for sector protection.

Once the sector is protected, the sector remains protected until next chip unprotect, or is temporarily unprotected by asserting RESET# pin at Vhv. Refer to temporary sector unprotect operation for further details.

This method is by applying Vhv on RESET# pin. Refer to Figure 12 for timing diagram and Figure 13 for the algorithm for this method.

#### **CHIP UNPROTECT OPERATION**

MX29F800C T/B provides one method for chip unprotect. The chip unprotect operation unprotects all sectors within the device. It is recommended to protect all sectors before activating chip unprotect mode. All sector are unprotected when shipped from the factory.

This method is by applying Vhv on RESET# pin. Refer to Figure 12 for timing diagram and Figure 13 for algorithm of the operation.

#### **TEMPORARY SECTOR UNPROTECT OPERATION**

System can apply RESET# pin at Vhv to place the device in temporary unprotect mode. In this mode, previously protected sectors can be programmed or erased just as it is unprotected. The devices returns to normal operation once Vhv is removed from RESET# pin and previously protected sectors are again protected.

#### **AUTOMATIC SELECT OPERATION**

When the device is in Read array mode or erase-suspended read array mode, user can issue read silicon ID command to enter read silicon ID mode. After entering read silicon ID mode, user can query several silicon IDs continuously and does not need to issue read silicon ID mode again. When A0 is Low, device will output Macronix Manufacture ID C2. When A0 is high, device will output Device ID. In read silicon ID mode, issuing reset command will reset device back to read array mode or erase-suspended read array mode.

Another way to enter read silicon ID is to apply high voltage on A9 pin with CE#, OE# and A1 at Vil. While the high voltage of A9 pin is discharged, device will automatically leave read silicon ID mode and go back to read array mode or erase-suspended read array mode. When A0 is Low, device will output Macronix Manufacture ID C2. When A0 is high, device will output Device ID.



#### **VERIFY SECTOR PROTECT STATUS OPERATION**

MX29F800C T/B provides hardware sector protection against Program and Erase operation for protected sectors. The sector protect status can be read through Sector Protect Verify command. This method requires  $V_{h\nu}$  on A9 pin, Vih on WE# and A1 pins, Vil on CE#, OE#, A6 and A0 pins, and sector address on A12 to A17 pins. If the read out data is 01H, the designated sector is protected. Oppositely, if the read out data is 00H, the designated sector is still not being protected.

#### **DATA PROTECTION**

To avoid accidental erasure or programming of the device, the device is automatically reset to read array mode during power up. Besides, only after successful completion of the specified command sets will the device begin its erase or program operation.

Other features to protect the data from accidental alternation are described as followed.

#### WRITE PULSE "GLITCH" PROTECTION

CE#, WE#, OE# pulses shorter than 5ns are treated as glitches and will not be regarded as an effective write cycle.

#### **LOGICAL INHIBIT**

A valid write cycle requires both CE# and WE# at Vil with OE# at Vih. Write cycle is ignored when either CE# at Vih, WE# a Vih, or OE# at Vil.

#### **POWER-UP SEQUENCE**

Upon power up, MX29F800C T/B is placed in read array mode. Furthermore, program or erase operation will begin only after successful completion of specified command sequences.

#### **POWER-UP WRITE INHIBIT**

When WE#, CE# is held at Vil and OE# is held at Vih during power up, the device ignores the first command on the rising edge of WE#.

#### **POWER SUPPLY DECOUPLING**

A 0.1uF capacitor should be connected between the Vcc and GND to reduce the noise effect.



### TABLE 3. MX29F800C T/B COMMAND DEFINITIONS

						Automat	ic Select		
Comma	Command		Reset Mode	Manufacturer ID		Devi	ce ID	Sector Pro	tect Verify
				Word	Byte	Word	Byte	Word	Byte
1st Bus	Addr	Addr	XXX	555	AAA	555	AAA	555	AAA
Cycle	Data	Data	F0	AA	AA	AA	AA	AA	AA
2nd Bus	Addr			2AA	555	2AA	555	2AA	555
Cycle	Data			55	55	55	55	55	55
3rd Bus	Addr			555	AAA	555	AAA	555	AAA
Cycle	Data			90	90	90	90	90	90
Atta Diva	Addr			X00	X00	X01	X02	(Sector)X02	(Sector)X04
4th Bus Cycle	Data			00C2	C2	ID	ID	XX00/XX01	00/01
5th Bus	Addr								
Cycle	Data								
6th Bus	Addr								
Cycle	Data			·					

Comma	ınd	Prog	gram	Chip	Erase	<del>                                     </del>		Erase Suspend	Erase Resume	Sector	Protect
		Word	Byte	Word	Byte	Word	Byte			Word	Byte
1st Bus	Addr	555	AAA	555	AAA	555	AAA	Sector	Sector	XXX	XXX
Cycle	Data	AA	AA	AA	AA	AA	AA	В0	30	60	60
2nd Bus	Addr	2AA	555	2AA	555	2AA	555			sector	sector
Cycle	Data	55	55	55	55	55	55			60	60
3rd Bus	Addr	555	AAA	555	AAA	555	AAA			sector	sector
Cycle	Data	A0	A0	80	80	80	80			40	40
4th Bus	Addr	Addr	Addr	555	AAA	555	AAA			sector	sector
Cycle	Data	Data	Data	AA	AA	AA	AA			00/01	00/01
5th Bus	Addr			2AA	555	2AA	555				
Cycle	Data			55	55	55	55				
6th Bus	Addr			555	AAA	Sector	Sector				
Cycle	Data			10	10	30	30				

### Notes:

- 1. Device ID: 22D6H/D6H for Top Boot Sector device. 2258H/58H for Bottom Boot Sector device.
- 2. For sector protect verify result, XX00H/00H means sector is not protected, XX01H/01H means sector has been protected.
- 3. Sector Protect command is valid during Vhv at RESET# pin, Vih at A1 pin and Vil at A0, A6 pins. The last Bus cyc is for protect verify.
- 4. It is not allowed to adopt any other code which is not in the above command definition table.



#### **RESET**

In the following situations, executing reset command will reset device back to read array mode:

- Among erase command sequence (before the full command set is completed)
- Sector erase time-out period
- Erase fail (while Q5 is high)
- Among program command sequence (before the full command set is completed, erase-suspended program included)
- Program fail (while Q5 is high, and erase-suspended program fail is included)
- · Read silicon ID mode
- · Sector protect verify

While device is at the status of program fail or erase fail (Q5 is high), user must issue reset command to reset device back to read array mode. While the device is in read silicon ID mode or sector protect verify mode, user must issue reset command to reset device back to read array mode.

When the device is in the progress of programming (not program fail) or erasing (not erase fail), device will ignore reset command.

#### **AUTOMATIC SELECT COMMAND SEQUENCE**

Automatic Select mode is used to access the manufacturer ID, device ID and to verify whether or not a sector is protected. The automatic select mode has four command cycles. The first two are unlock cycles, and followed by a specific command. The fourth cycle is a normal read cycle, and user can read at any address any number of times without entering another command sequence. The reset command is necessary to exit the Automatic Select mode and back to read array. The following table shows the identification code with corresponding address.

		Address	Data (Hex)	Representation
Manufacturer ID	Word	X00	00C2	
Manufacturer 1D	Byte	X00	C2	
Doving ID	Word	X01	22D6/2258	Top/Bottom Boot Sector
Device ID	Byte	X02	D6/58	Top/Bottom Boot Sector
Sector Protect Verify	Word	(Sector address) X 02	00/01	Unprotected/protected
Sector Protect Verify	Byte	(Sector address) X 04	00/01	Unprotected/protected

There is an alternative method to that shown in Table 2, which is intended for EPROM programmers and requires Vhv on address bit A9.



#### **AUTOMATIC PROGRAMMING**

The MX29F800C T/B can provide the user program function by the form of Byte-Mode or Word-Mode. As long as the users enter the right cycle defined in the Table.3 (including 2 unlock cycles and A0H), any data user inputs will automatically be programmed into the array.

Once the program function is executed, the internal write state controller will automatically execute the algorithms and timings necessary for program and verification, which includes generating suitable program pulse, verifying whether the threshold voltage of the programmed cell is high enough and repeating the program pulse if any of the cells does not pass verification. Meanwhile, the internal control will prohibit the programming to cells that pass verification while the other cells fail in verification in order to avoid over-programming.

Programming will only change the bit status from "1" to "0". That is to say, it is impossible to convert the bit status from "0" to "1" by programming. Meanwhile, the internal write verification only detects the errors of the "1" that is not successfully programmed to "0".

Any command written to the device during programming will be ignored except hardware reset, which will terminate the program operation after a period of time no more than Tready. When the embedded program algorithm is complete or the program operation is terminated by hardware reset, the device will return to the reading array data mode.

With the internal write state controller, the device requires the user to write the program command and data only. The typical chip program time at room temperature of the MX29F800C T/B is 3 seconds. (Word-Mode)

When the embedded program operation is on going, user can confirm if the embedded operation is finished or not by the following methods:

Status	Q7	Q6	Q5	RY/BY#*2
In progress*1	Q7#	Toggling	0	0
Finished	Q7	Stop toggling	0	1
Exceed time limit	Q7#	Toggling	1	0

<sup>\*1:</sup> The status "in progress" means both program mode and erase-suspended program mode.

<sup>\*2:</sup> RY/BY# is an open drain output pin and should be weakly connected to VDD through a pull-up resistor.

<sup>\*3:</sup> When an attempt is made to program a protected sector, Q7 will output its complement data or Q6 continues to toggle for about 1us and the device returns to read array state without programing the data in the protected sector.



#### **CHIP ERASE**

Chip Erase is to erase all the data with "1" and "0" as all "1". It needs 6 cycles to write the action in, and the first two cycles are "unlock" cycles, the third one is a configuration cycle, the fourth and fifth are also "unlock" cycles, and the sixth cycle is the chip erase operation.

During chip erasing, all the commands will not be accepted except hardware rests or the working voltage is too low that chip erase will be interrupted. After Chip Erase, the chip will return to the state of Read Array.

When the embedded chip erase operation is on going, user can confirm if the embedded operation is finished or not by the following methods:

Status	Q7	Q6	Q5	Q2	RY/BY#
In progress	0	Toggling	0	Toggling	0
Finished	1	Stop toggling	0	1	1
Exceed time limit	0	Toggling	1	Toggling	0

#### **SECTOR ERASE**

Sector Erase is to erase all the data in a sector with "1" and "0" as all "1". It requires six command cycles to issue. The first two cycles are "unlock cycles", the third one is a configuration cycle, the fourth and fifth are also "unlock cycles" and the sixth cycle is the sector erase command. After the sector erase command sequence is issued, there is a time-out period of 40us counted internally. During the time-out period, additional sector address and sector erase command can be written multiply. Once user enters another sector erase command, the time-out period of 40us is recounted. If user enters any command other than sector erase or erase suspend during time-out period, the erase command would be aborted and the device is reset to read array condition. The number of sectors could be from one sector to all sectors. After time-out period passing by, additional erase command is not accepted and erase embedded operation begins.

During sector erasing, all commands will not be accepted except hardware reset and erase suspend and user can check the status as chip erase.

When the embedded erase operation is on going, user can confirm if the embedded operation is finished or not by the following methods:

Status	Q7	Q6	Q5	Q3	Q2	RY/BY#*2
Time-out period	0	Toggling	0	0	Toggling	0
In progress	0	Toggling	0	1	Toggling	0
Finished	1	Stop toggling	0	1	1	1
Exceed time limit	0	Toggling	1	1	Toggling	0

<sup>\*1:</sup> The status Q3 is the time-out period indicator. When Q3=0, the device is in time-out period and is acceptible to another sector address to be erased. When Q3=1, the device is in erase operation and only erase suspend is valid.

<sup>\*2:</sup> RY/BY# is open drain output pin and should be weakly connected to VDD through a pull-up resistor.

<sup>\*3:</sup> When an attempt is made to erase a protected sector, Q7 will output its complement data or Q6 continues to toggle for 100us and the device returned to read array status without erasing the data in the protected sector.



#### **SECTOR ERASE SUSPEND**

During sector erasure, sector erase suspend is the only valid command. If user issue erase suspend command in the time-out period of sector erasure, device time-out period will be over immediately and the device will go back to erase-suspended read array mode. If user issue erase suspend command during the sector erase is being operated, device will suspend the ongoing erase operation, and after the Tready1(<=20us) suspend finishes and the device will enter erase-suspended read array mode. User can judge if the device has finished erase suspend through Q6, Q7, and RY/BY#.

After device has entered erase-suspended read array mode, user can read other sectors not at erase suspend by the speed of Taa; while reading the sector in erase-suspend mode, device will output its status. User can use Q6 and Q2 to judge the sector is erasing or the erase is suspended.

Status	Q7	Q6	Q5	Q3	Q2	RY/BY#
Erase suspend read in erase suspended sector	1	No toggle	0	N/A	Toggle	1
Erase suspend read in non-erase suspended sector	Data	Data	Data	Data	Data	1
Erase suspend program in non-erase suspended sector	Q7#	Toggle	0	N/A	N/A	0

When the device has suspended erasing, user can execute the command sets except sector erase and chip erase, such as read silicon ID, sector protect verify, program, and erase resume.

#### **SECTOR ERASE RESUME**

Sector erase resume command is valid only when the device is in erase suspend state. After erase resume, user can issue another erase suspend command, but there should be a 400us interval between erase resume and the next erase suspend. If user issue infinite suspend-resume loop, or suspend-resume exceeds 1024 times, the time for erasing will increase.



### **ABSOLUTE MAXIMUM STRESS RATINGS**

Surrounding Temperature with	Bias	-65°C to +125°C
Storage Temperature	-65°C to +150°C	
	VCC	-0.5V to +7.0V
Voltage Range	RESET#, A9	-0.5V to +12.5V
	The other pins.	-0.5V to VCC+0.7V
Output Short Circuit Current (I	200 mA	

### **OPERATING TEMPERATURE AND VOLTAGE**

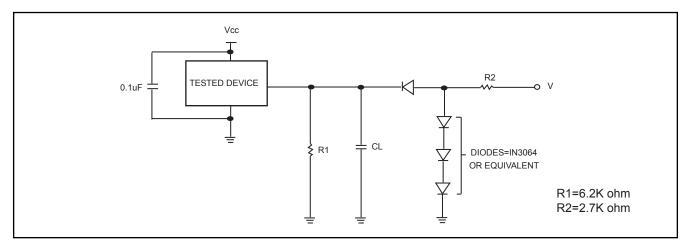
Commercial (C) Grade	Surrounding Temperature (TA)	0°C to +70°C		
Industrial (I) Grade	Surrounding Temperature (TA)	-40°C to +85°C		
VCC Supply Voltages	VCC range	+4.5 V to 5.5 V		



### **DC CHARACTERISTICS**

Symbol	Description	Min	Тур	Max	Remark
lilk	Input Leak			±1.0uA	
lolk	Output Leak			10uA	
lilk9	A9 Leak			35uA	A9: 12.5V
Icr1	Read Current (10MHz)			50mA	CE#=Vil, OE#=Vih
lcr2	Read Current (5MHz)			40mA	CE#=Vil, OE#=Vih
lsb1	Standby Current (TTL)			1mA	Vcc=Vcc max, CE#=Vih other pin disable
lsb2	Standby current (CMOS)		1uA	50uA	Vcc=Vccmax, CE#=vcc +0.3V, other pin disable
Icw	Write Current			50mA	CE#=Vil, OE#=Vih, WE#=Vil
Vil	Input Low Voltage	-0.3V		V8.0	
Vih	Input High Voltage	0.7xVcc		Vcc+0.3V	
Vhv	Very High Voltage for hardware Protect/ Unprotect/Auto Select/ Temporary Unprotect	11.5V	12V	12.5V	
Vol	Output Low Voltage			0.45V	Iol=2.1mA, Vcc=Vcc min
Voh1	Ouput High Voltage (TTL)	2.4V			loh1=-2mA
Voh2	Ouput High Voltage (CMOS)	Vcc-0.4V			loh2=-100uA

### **SWITCHING TEST CIRCUITS**



**Test Condition** 

Output Load: 1 TTL gate

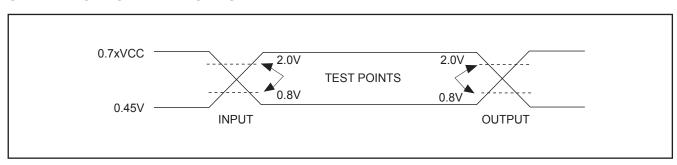
Output Load Capacitance, CL: 30PF for 70ns

Rise/Fall Times: 10ns

Input pulse levels: 0.45V/0.7xVcc

Reference levels for measuring timing :0.8V, 2.0V

#### **SWITCHING TEST WAVEFORMS**

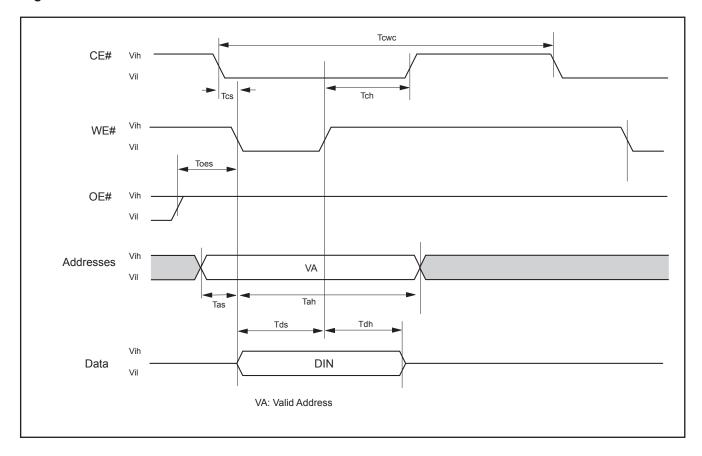




### **AC CHARACTERISTICS**

Symbol	December 1 and 1 a	Spe				
	Description			Тур.	Max.	Unit
Taa	Valid data output after address			ĺ	70	ns
Tce	Valid data output after CE# low				70	ns
Toe	Valid data output after OE# low				30	ns
Tdf	Data output floating after OE# high				20	ns
Toh	Output hold time from the earliest rising edge of Address, CE#, OE#					ns
Twc	Write period time					ns
Tcwc	Command write period time					ns
Tas	Address setup time		0			ns
Tah	Address hold time		45			ns
Tds	Data setup time		30			ns
Tdh	Data hold time		0			ns
Tcs	CE# Setup time		0			ns
Tch	CE# hold time		0			ns
Toes	Output enable setup time		0			ns
Тсер	CE# pulse width		35			ns
Tceph	CE# pulse width high		20			ns
Tbusy	Program/Erase active time by RY/BY#			ĺ	90	ns
Tavt	Program operation	Byte		9	300	us
		Word		11	360	us
Taetc	Chip Erase operation			8	32	sec
Taetb	Sector Erase operation			0.7	15	sec
Tbal	Sector address hold time				40	us

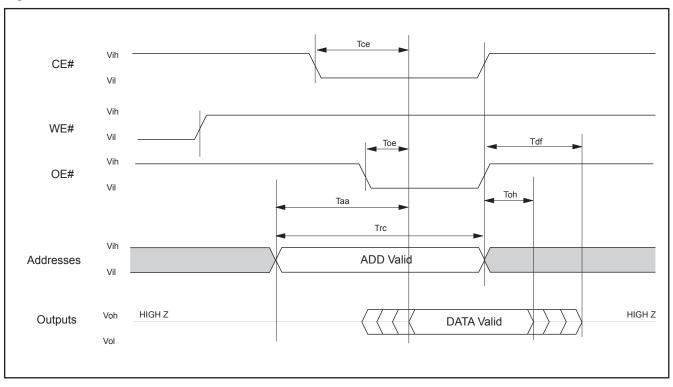
Figure 1. COMMAND WRITE OPERATION





### **READ/RESET OPERATION**

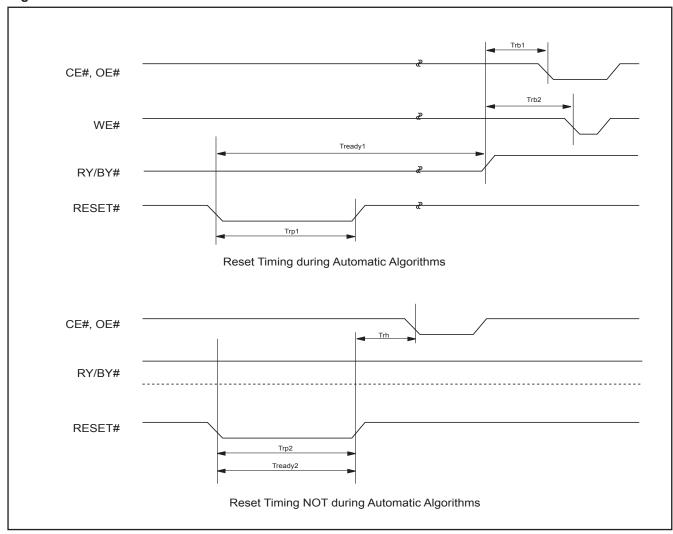
### Figure 2. READ TIMING WAVEFORMS



### **AC CHARACTERISTICS**

Item	Description	Setup	Speed	Unit
Trp1	RESET# Pulse Width (During Automatic Algorithms)	MIN	10	us
Trp2	RESET# Pulse Width (NOT During Automatic Algorithms)	MIN	500	ns
Trh	RESET# High Time Before Read	MIN	0	ns
Trb1	RY/BY# Recovery Time (to CE#, OE# go low)	MIN	0	ns
Trb2	RY/BY# Recovery Time (to WE# go low)	MIN	50	ns
Tready1	RESET# PIN Low (During Automatic Algorithms) to Read or Write	MAX	20	us
Tready2	RESET# PIN Low (NOT During Automatic Algorithms) to Read or Write	MAX	500	ns

Figure 3. RESET# TIMING WAVEFORM



### **ERASE/PROGRAM OPERATION**

Figure 4. AUTOMATIC CHIP ERASE TIMING WAVEFORM

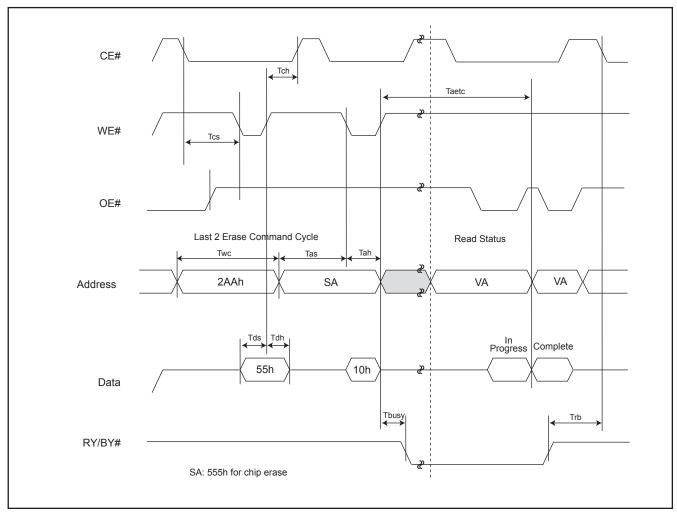




Figure 5. AUTOMATIC CHIP ERASE ALGORITHM FLOWCHART

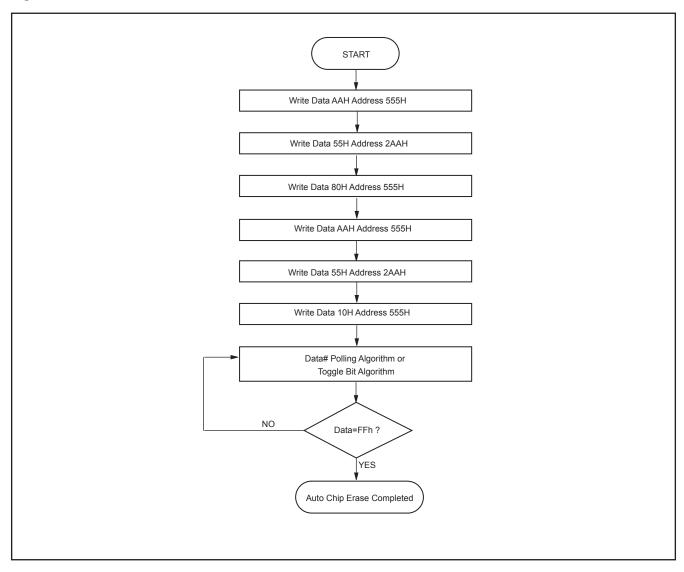




Figure 6. AUTOMATIC SECTOR ERASE TIMING WAVEFORM

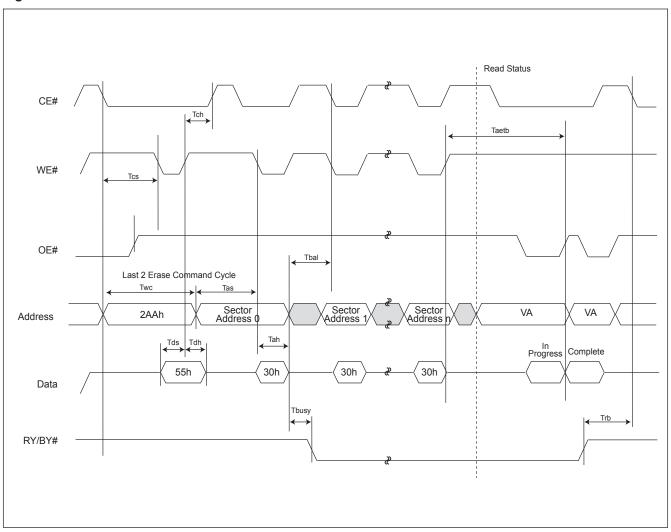




Figure 7. AUTOMATIC SECTOR ERASE ALGORITHM FLOWCHART

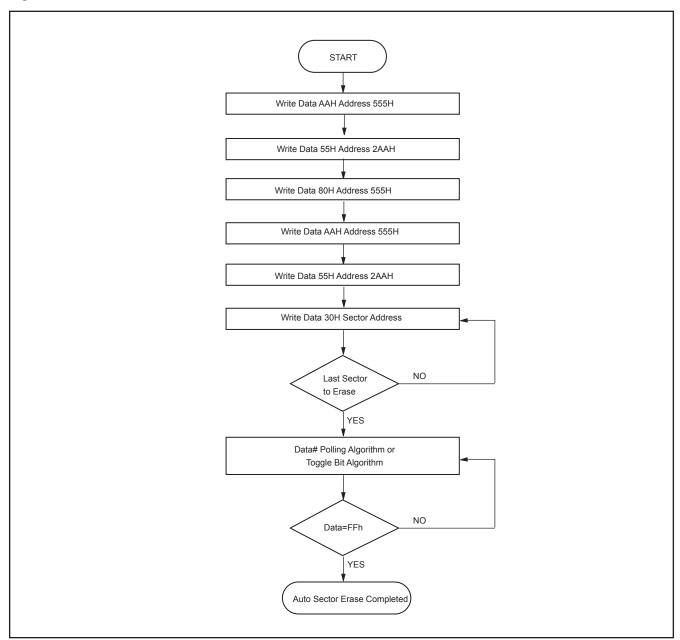




Figure 8. ERASE SUSPEND/RESUME FLOWCHART

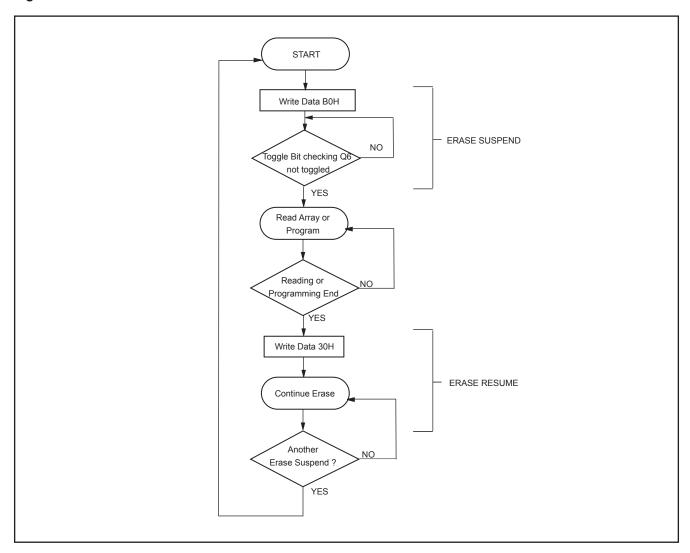




Figure 9. AUTOMATIC PROGRAM TIMING WAVEFORMS

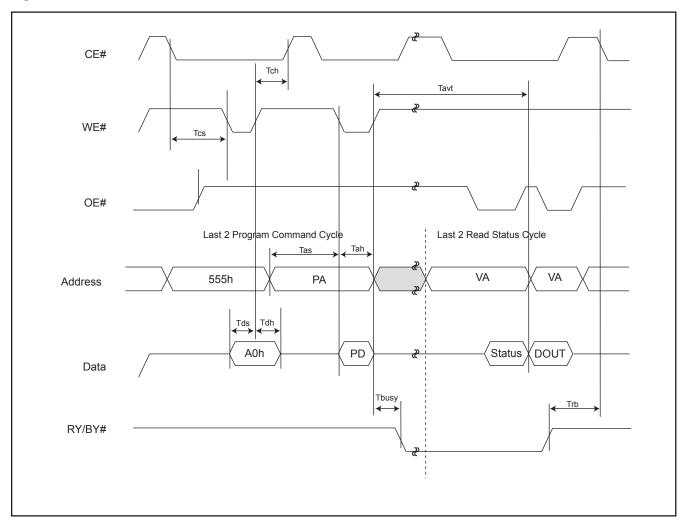




Figure 10. CE# CONTROLLED WRITE TIMING WAVEFORM

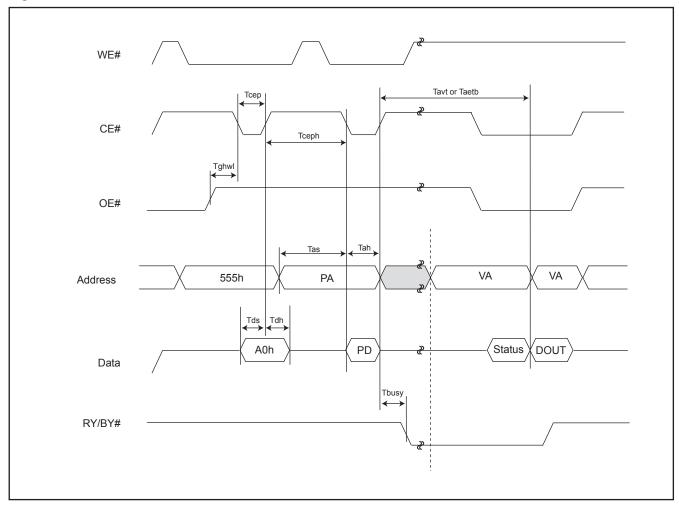
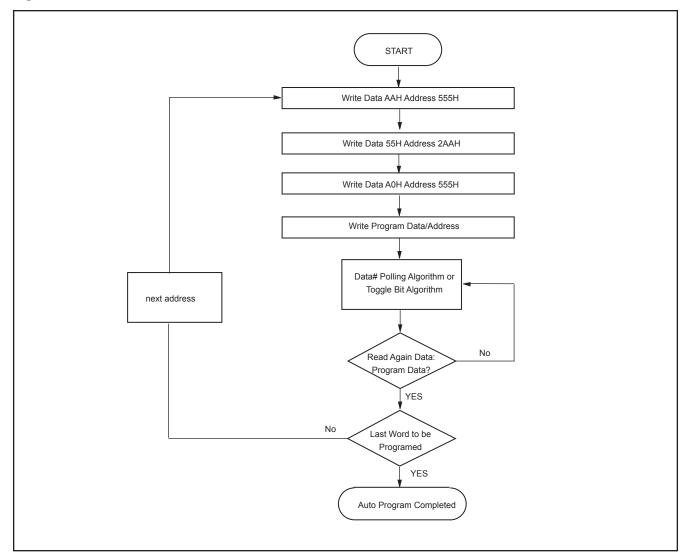




Figure 11. AUTOMATIC PROGRAMMING ALGORITHM FLOWCHART



### SECTOR PROTECT/CHIP UNPROTECT

Figure 12. SECTOR PROTECT/CHIP UNPROTECT WAVEFORM (RESET# Control)

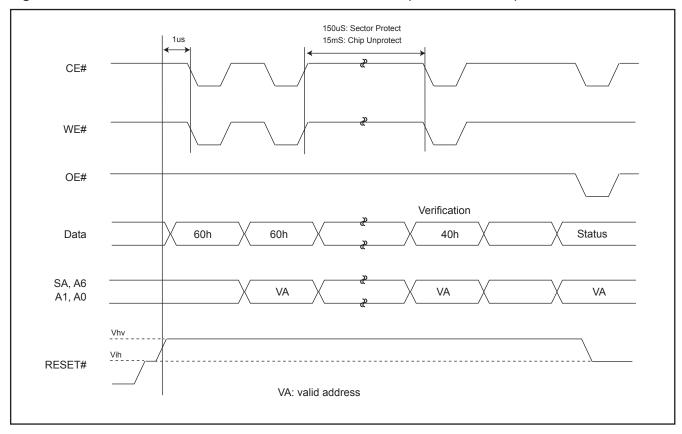




Figure 13-1. IN-SYSTEM SECTOR PROTECT WITH RESET#=Vhv

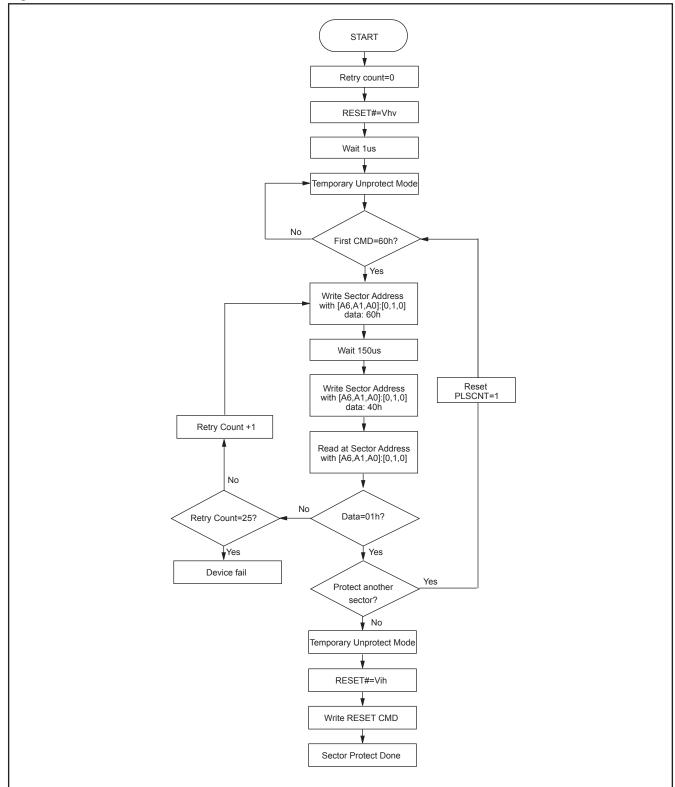
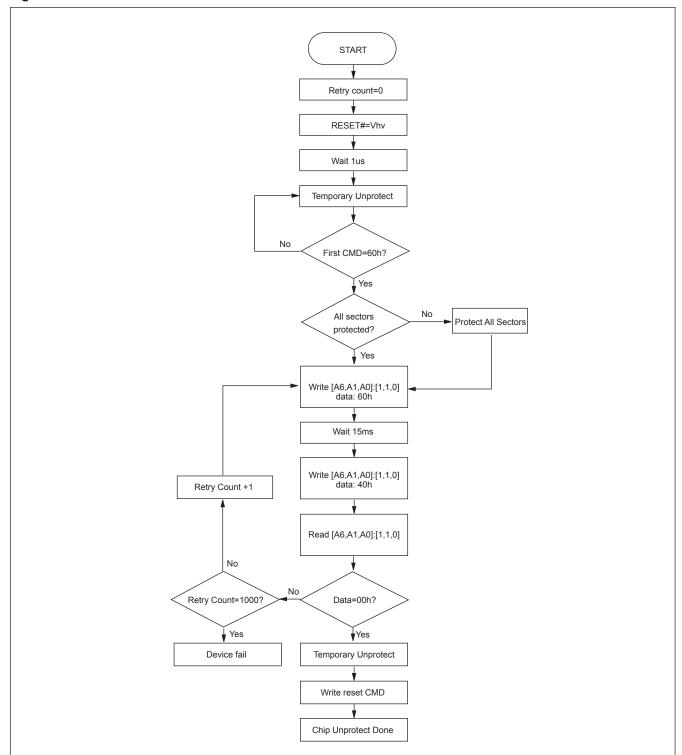




Figure 13-2. CHIP UNPROTECT ALGORITHMS WITH RESET#=Vhv





### **Table 5. TEMPORARY SECTOR UNPROTECT**

Parameter	Alt	Description	Condition	Speed	Unit
Trpvhh	Tvidr	RESET# Rise Time to Vhv and Vhv Fall Time to RESET#	MIN	500	ns
Tvhhwl	Trsp	RESET# Vhv to WE# Low	MIN	4	us

Figure 14. TEMPORARY SECTOR UNPROTECT WAVEFORMS

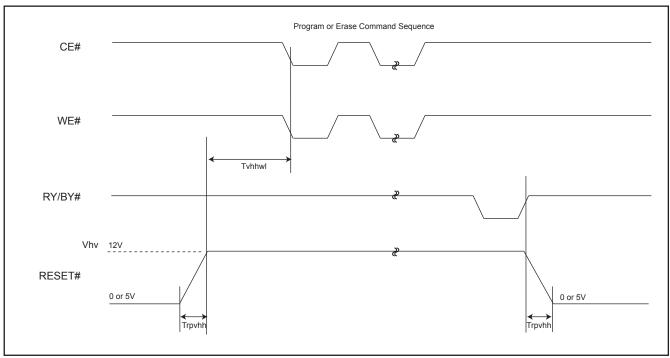
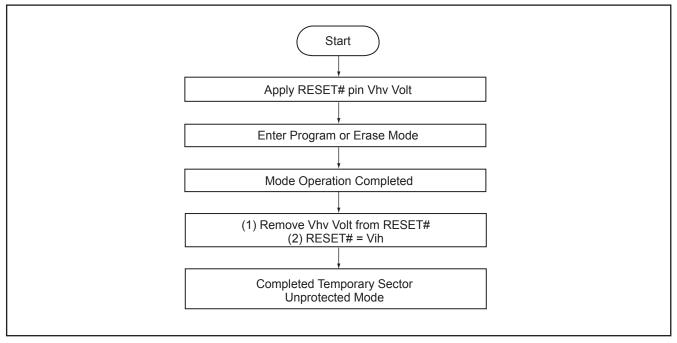




Figure 15. TEMPORARY SECTOR UNPROTECT FLOWCHART

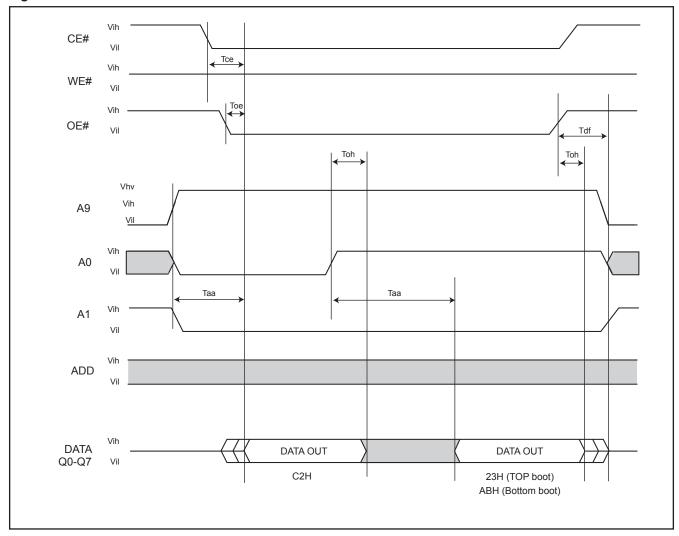


#### Notes:

- 1. Temporary unprotect all protected sectors Vhv=11.5 ~ 12.5V.
- 2. The protected conditions of the protected sectors are the same to temporary sector unprotect mode.



Figure 16. SILICON ID READ TIMING WAVEFORM



### **WRITE OPERATION STATUS**

Figure 17. DATA# POLLING TIMING WAVEFORMS (DURING AUTOMATIC ALGORITHMS)

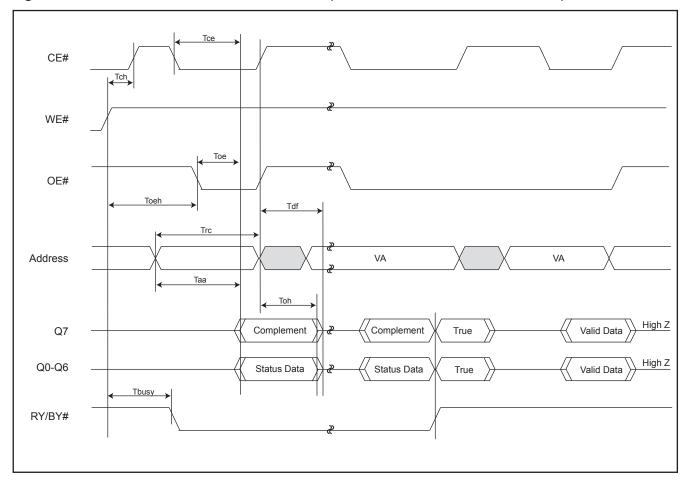
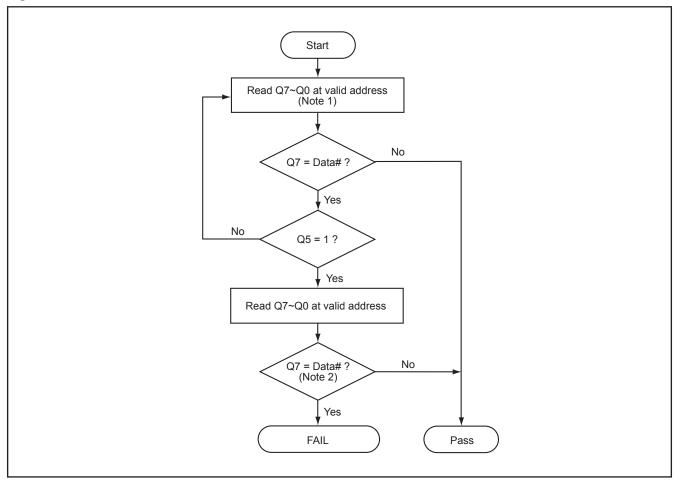


Figure 18. DATA# POLLING ALGORITHM



### Notes:

- 1. For programming, valid address means program address. For erasing, valid address means erase sectors address.
- 2. Q7 should be rechecked even Q5="1" because Q7 may change simultaneously with Q5.



Figure 19. TOGGLE BIT TIMING WAVEFORMS (DURING AUTOMATIC ALGORITHMS)

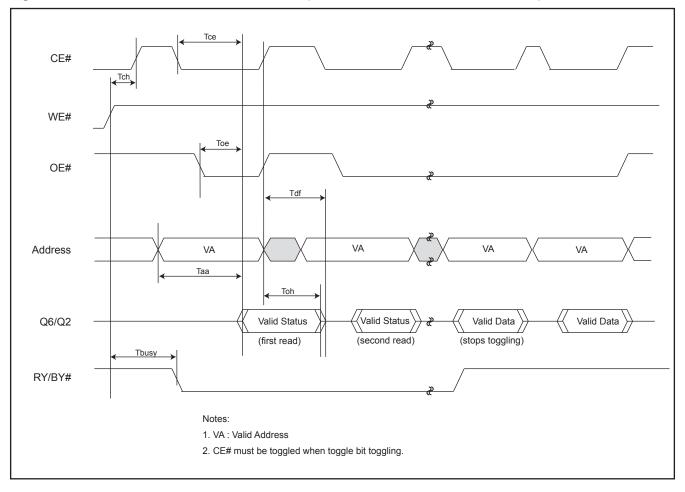
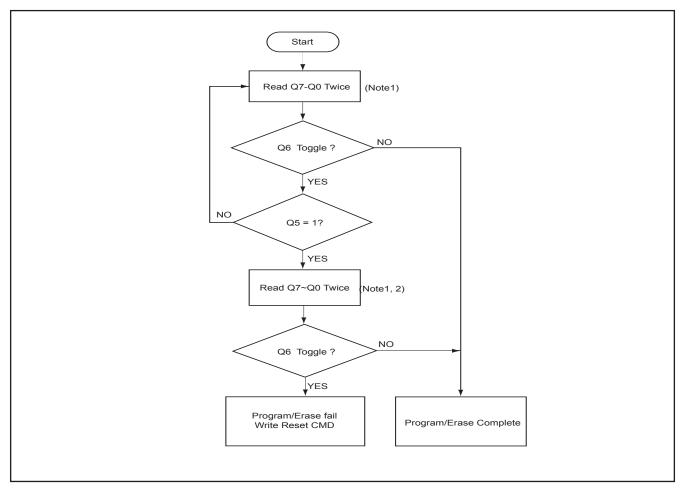


Figure 20. TOGGLE BIT ALGORITHM



## Notes:

- 1. Read toggle bit twice to determine whether or not it is toggling.
- 2. Recheck toggle bit because it may stop toggling as Q5 changes to "1".

## **RECOMMENDED OPERATING CONDITIONS**

## At Device Power-Up

AC timing illustrated in Figure A is recommended for the supply voltages and the control signals at device power-up. If the timing in the figure is ignored, the device may not operate correctly.

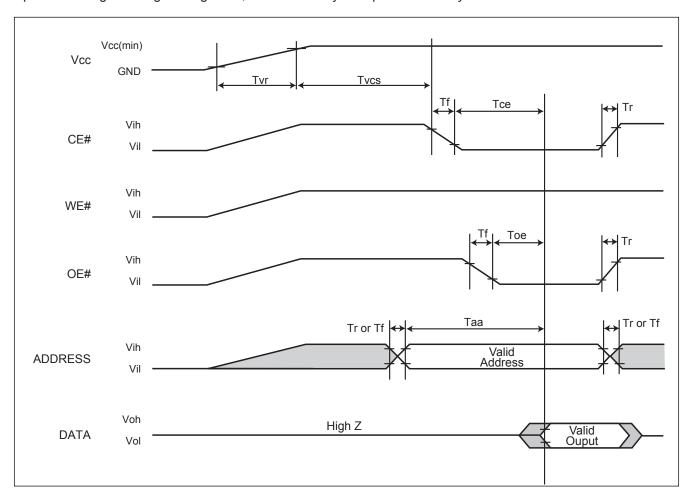


Figure A. AC Timing at Device Power-Up

Symbol	Parameter	Min.	Max.	Unit
Tvr	Vcc Rise Time	20	500000	us/V
Tr	Input Signal Rise Time		20	us/V
Tf	Input Signal Fall Time		20	us/V

P/N:PM1493 REV. 1.0, NOV. 17, 2009



## **ERASE AND PROGRAMMING PERFORMANCE**

PARAMETER			UNITS		
		MIN.	TYP.	MAX.	
Byte Programming Time			9	300	us
Word Programming Time			11	360	us
Sector Erase Time			0.7	8	sec
Chip Erase Time			8	32	sec
Chin Drogramming Time	Byte Mode		10	27	sec
Chip Programming Time	Word Mode		7.5	17	sec
Erase/Program Cycles		100,000			Cycles

- Note: 1. Typical condition means 25°C, 5V.
  - 2. Maximum condition means 85°C, 4.5V, 100K cycles.

## **LATCH-UP CHARACTERISTICS**

	MIN.	MAX.
Input Voltage voltage difference with GND on A9, Reset# pins	-1.0V	12.5V
Input Voltage voltage difference with GND on all normal pins inputs	-1.0V	Vcc + 1.0V
Input current pulse	-100mA	+100mA
Includes all pins except Vcc. Test conditions: Vcc = 5V, one pin per testing		

## **TSOP PIN CAPACITANCE**

Parameter Symbol	Parameter Description	Test Set	TYP	MAX	UNIT
CIN2	Control Pin Capacitance	VIN=0		12	pF
COUT	Output Capacitance	VOUT=0		12	pF
CIN	Input Capacitance	VIN=0		8	pF

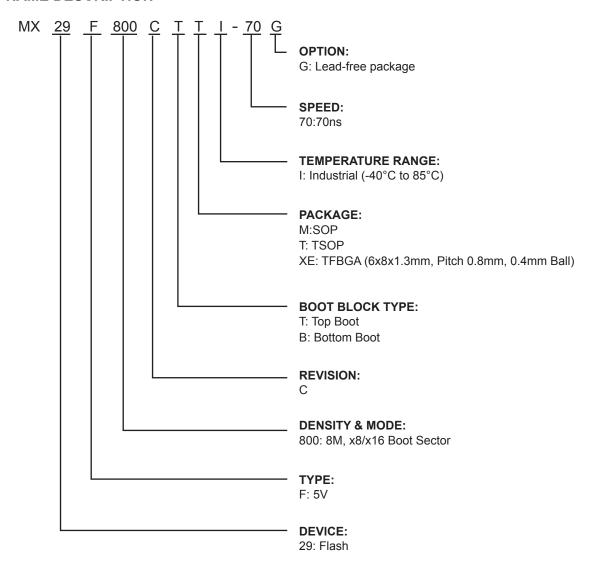


## **ORDERING INFORMATION**

PART NO.	ACCESS TIME (ns)	Temperature Range	PACKAGE	Remark
MX29F800CTMI-70G	70	-40°C~85°C	44 Pin SOP	PB-free
MX29F800CBMI-70G	70	-40°C~85°C	44 Pin SOP	PB-free
MX29F800CTTI-70G	70	-40°C~85°C	48 Pin TSOP (Normal Type)	PB-free
MX29F800CBTI-70G	70	-40°C~85°C	48 Pin TSOP (Normal Type)	PB-free
MX29F800CTXEI-70G	70	-40°C~85°C	48 Ball TFBGA (6x8mm)	PB-free
MX29F800CBXEI-70G	70	-40°C~85°C	48 Ball TFBGA (6x8mm)	PB-free

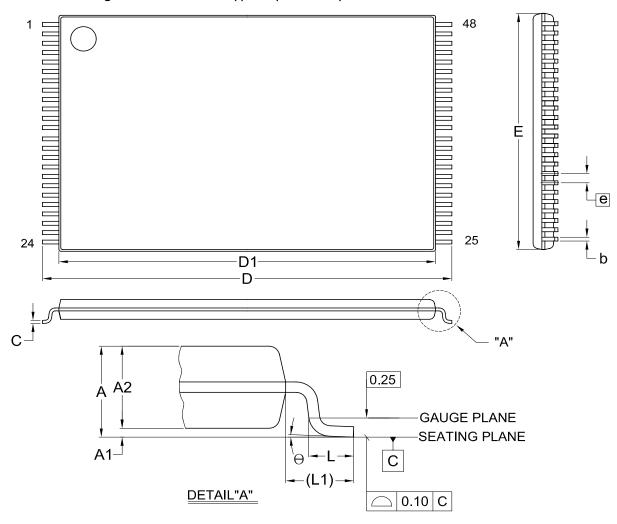


## PART NAME DESCRIPTION



## **PACKAGE INFORMATION**

Title: Package Outline for TSOP(I) 48L (12X20mm)NORMAL FORM

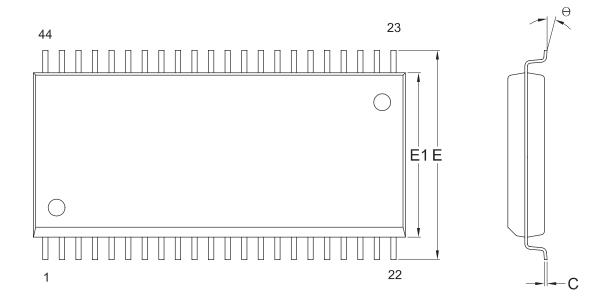


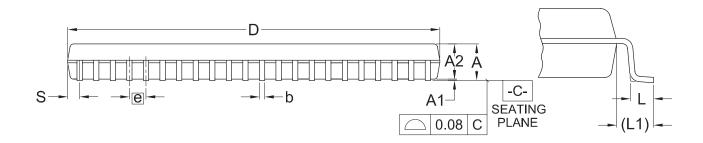
Dimensions (inch dimensions are derived from the original mm dimensions)

SY	MBOL	Δ.	A 4	A2	<b>L</b>	С	D	D1	E	_		1.4	
UNIT		А	A1	AZ	b	C	ט	וט	Ц	е		L1	Θ
	Min.	1	0.05	0.95	0.17	0.10	19.80	18.30	11.90	-	0.50	0.70	0
mm	Nom.		0.10	1.00	0.20	0.13	20.00	18.40	12.00	0.50	0.60	0.80	5
	Max.	1.20	0.15	1.05	0.27	0.21	20.20	18.50	12.10		0.70	0.90	8
	Min.		0.002	0.037	0.007	0.004	0.780	0.720	0.469	l	0.020	0.028	0
Inch	Nom.	-	0.004	0.039	0.008	0.005	0.787	0.724	0.472	0.020	0.024	0.031	5
	Max.	0.047	0.006	0.041	0.011	0.008	0.795	0.728	0.476	-	0.028	0.035	8

DWC NO	REVISION		ISSUE DATE			
DWG.NO.	REVISION	JEDEC EIAJ			ISSUE DATE	
6110-1607	8	MO <b>-</b> 142			2007/08/03	

Doc. Title: Package Outline for SOP 44L (500MIL)





Dimensions (inch dimensions are derived from the original mm dimensions)

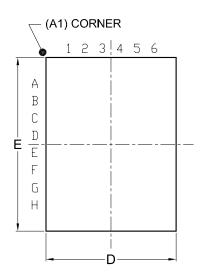
SY UNIT	MBOL	A	A1	A2	b	С	D	Е	E1	е	L	L1	S	θ
	Min.		0.10	2.59	0.36	0.15	28.37	15.83	12.47		0.56	1.51	0.78	0
mm	Nom.		0.15	2.69	0.41	0.20	28.50	16.03	12.60	1.27	0.76	1.71	0.91	5
	Max.	3.00	0.20	2.80	0.51	0.25	28.63	16.23	12.73		0.96	1.91	1.04	10
	Min.		0.004	0.102	0.014	0.006	1.117	0.623	0.491		0.022	0.059	0.031	0
Inch	Nom.	_	0.006	0.106	0.016	0.008	1.122	0.631	0.496	0.050	0.030	0.067	0.036	5
	Max.	0.118	0.008	0.110	0.020	0.010	1.127	0.639	0.501		0.038	0.075	0.041	10

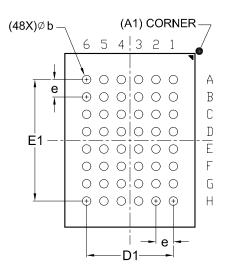
DWG.NO.	REVISION		REFERENCE			
DWG.NO.	REVISION	JEDEC	EIAJ		ISSUE DATE	
6110-1405	7	MO-175			2008/02/18	

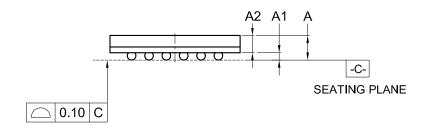
## Title: Package Outline for CSP 48BALL(6X8X1.3MM,BALL PITCH 0.8MM,BALL DIAMETER 0.4MM)

**TOP VIEW** 

**BOTTOM VIEW** 







Dimensions (inch dimensions are derived from the original mm dimensions)

UNIT	MBOL	Α	<b>A</b> 1	A2	b	D	D1	ш	E1	e
	Min.		0.25	0.65	0.35	5.90		7.90		
mm	Nom.		0.30		0.40	6.00	4.00	8.00	5.60	0.80
	Max.	1.30	0.35		0.45	6.10		8.10		
	Min.		0.010	0.026	0.014	0.232		0.311		
Inch	Nom.		0.012	_	0.016	0.236	0.157	0.315	0.220	0.031
	Max.	0.051	0.014	l	0.018	0.240		0.319		

DWC NO	REVISION		ICCUE DATE			
DWG.NO.	REVISION	JEDEC	EIAJ		ISSUE DATE	
6110-4202	4	MO-219			12-12-'03	



## **REVISION HISTORY**

**Revision No. Description** 

1.0

 Removed "Preliminary"
Removed 90ns grade at Order Information 3. Modified Tbal spec from 50us to 40us 4. Modified typical chip programming time

Page **Date** 

P1 NOV/17/2009

P1,18,42,43 P13,17 P41



Macronix's products are not designed, manufactured, or intended for use for any high risk applications in which the failure of a single component could cause death, personal injury, severe physical damage, or other substantial harm to persons or property, such as life-support systems, high temperature automotive, medical, aircraft and military application. Macronix and its suppliers will not be liable to you and/or any third party for any claims, injuries or damages that may be incurred due to use of Macronix's products in the prohibited applications.

Copyright© Macronix International Co., Ltd. 2009. All Rights Reserved. Macronix, MXIC, MXIC Logo, MX Logo, are trademarks or registered trademarks of Macronix International Co., Ltd.. The names and brands of other companies are for identification purposes only and may be claimed as the property of the respective companies.

## MACRONIX INTERNATIONAL CO., LTD.

#### Macronix Offices: Taiwan Headquarters, FAB2

### Macronix, International Co., Ltd.

16, Li-Hsin Road, Science Park, Hsinchu,

Taiwan, R.O.C. Tel: +886-3-5786688

Fax: +886-3-5632888

#### Taipei Office

#### Macronix, International Co., Ltd.

19F, 4, Min-Chuan E. Road, Sec. 3, Taipei,

Taiwan, R.O.C.

Tel: +886-2-2509-3300 Fax: +886-2-2509-2200

#### **Macronix Offices: China**

### Macronix (Hong Kong) Co., Limited.

702-703, 7/F, Building 9, Hong Kong Science Park, 5 Science Park West Avenue, Sha Tin,

N.T.

Tel: +86-852-2607-4289 Fax: +86-852-2607-4229

# Macronix (Hong Kong) Co., Limited, SuZhou Office

 $No.5,\,XingHai\;Rd,\,SuZhou\;Industrial\;Park,$ 

SuZhou China 215021

Tel: +86-512-62580888 Ext: 3300

Fax: +86-512-62586799

# Macronix (Hong Kong) Co., Limited, Shenzhen Office

Room 1401 & 1404, Block A, TianAN Hi-Tech PLAZA Tower,

Che Gong Miao, Futian District, Shenzhen PRC 518040

Tel: +86-755-83433579 Fax: +86-755-83438078

#### http://www.macronix.com

### Macronix Offices: Japan Macronix Asia Limited.

#### William Asia Ellinicu.

NKF Bldg. 5F, 1-2 Higashida-cho, Kawasaki-ku Kawasaki-shi, Kanagawa Pref. 210-0005, Japan

Tel: +81-44-246-9100 Fax: +81-44-246-9105

#### **Macronix Offices: Korea**

#### Macronix Asia Limited.

#906, 9F, Kangnam Bldg., 1321-4, Seocho-Dong, Seocho-Ku,

135-070, Seoul, Korea Tel: +82-02-588-6887 Fax: +82-02-588-6828

#### **Macronix Offices: Singapore**

#### Macronix Pte. Ltd.

1 Marine Parade Central, #11-03 Parkway Centre,

Singapore 449408 Tel: +65-6346-5505 Fax: +65-6348-8096

# Macronix Offices: Europe Macronix Europe N.V.

### Koningin Astridlaan 59, Bus 1 1780

Wemmel Belgium Tel: +32-2-456-8020 Fax: +32-2-456-8021

## Macronix Offices : USA

#### Macronix America, Inc.

 $680\ North\ McCarthy\ Blvd.\ Milpitas,\ CA\ 95035,$ 

U.S.A.

Tel: +1-408-262-8887 Fax: +1-408-262-8810